

**Search Notes**

Application/Control No.

10/670,618

Examiner

Benjamin Huh

Applicant(s)/Patent under  
Reexamination

FLOCK ET AL.

Art Unit

3767

**SEARCHED**

Class	Subclass	Date	Examiner
604	20, 22, 27, 31-32, 37- 40, 82-84	5/23/2006	BHH
606	4	5/23/2006	BHH
606	41-49	5/23/2006	BHH
604	503	5/23/2006	BHH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	5/23/2006	BHH
Search Updated	5/23/2006	BHH
Search Updated	2/16/2007	BHH